

**Search Notes**

Application/Control No.

10/604,859

Examiner

Nathan Wiehe

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
415	121.2	2/1/2006	NEW
416	247R	2/1/2006	NEW
454	184	2/1/2006	NEW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
415/121.2 416/247R Rich Edgar	2/1/2006	NEW
454/184 Ed Look	2/1/2006	
Text Search in 165/80.3;361/965 Rich Edgar	2/1/2006	
Text Search (See EAST search History)	2/1/2006	
Inventor Name Search	2/1/2006	NEW